

FEATURES

- Turn On Current (I_{FT}), 5.0 mA Typical
- Gate Trigger Current (I_{GT}), 20 mA Typical
- Surge Anode Current, 5.0 A
- Blocking Voltage, 400 V Gate Trigger Voltage (V_{GT}), 0.6 V Typical
- Isolation Voltage, 5300 V_{RMS}
- Solid State Reliability
- Standard DIP Package
- Underwriters Lab File #E52744

DESCRIPTION

The H11C4/H11C5/H11C6 are optically coupled SCRs with a Gallium Arsenide infrared emitter and a silicon photo SCR sensor. Switching can be achieved while maintaining a high degree of isolation between triggering and load circuits. These optocouplers can be used in SCR triac and solid state relay applications where high blocking voltages and low input current sensitivity are required.

The H11C4 and H11C5 are identical and have a maximum turn-on-current of 11 mA. The H11C6 has a maximum of 14 mA.

Maximum Ratings

Emitter

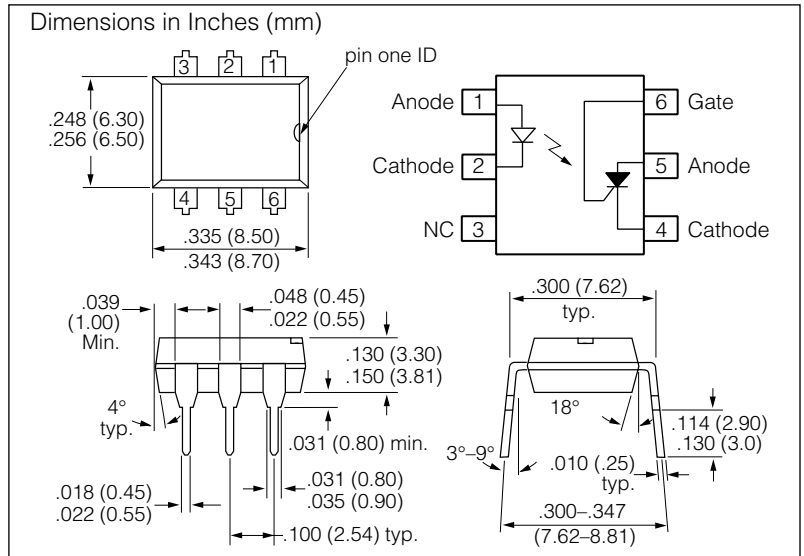
Peak Reverse Voltage 6.0 V
 Continuous Forward Current 60 mA
 Peak Forward Current (1.0 ms, 1% Duty Cycle).....3.0 A
 Power Dissipation at 25°C..... 100 mW
 Derate Linearly from 25°C..... 1.33 mW/°C

Detector

Reverse Gate Voltage..... 6.0 V
 Anode Voltage (DC or AC Peak) 400 V
 RMS Forward Current.....300 mA
 Surge Anode Current (10 ms duration)5.0 A
 Peak Forward Current (100 μs, 1% Duty Cycle) .. 10 A
 Surge Gate Current (5.0 ms duration).....200 mA
 Power Dissipation, 25°C case..... 1000 mW
 Derate Linearly from 25°C..... 13.3 mW/°C

Package

Isolation Test Voltage.....5300 V_{RMS}
 (between emitter and detector referred to
 Standard Climate23°C/50%RH, DIN 50014)
 Creepage ≥7.0 mm
 Clearance ≥7.0 mm
 Comparative Tracking Index per
 DIN IEC 112/VDE 0303, part 1 175
 Isolation Resistance
 $V_{IO}=500\text{ V}, T_A=25^\circ\text{C}$ ≥10¹² Ω
 $V_{IO}=500\text{ V}, T_A=100^\circ\text{C}$ ≥10¹¹ Ω
 Total Package Dissipation 400 mW
 Derate Linearly from 25°C..... 5.3 mW/°C
 Operating Temperature Range.....-55°C to +100°C
 Storage Temperature Range-55°C to +150°C
 Lead Soldering Time at 260°C 10 sec.



Characteristics $T_A=25^\circ\text{C}$

Parameters	Sym	Min.	Typ.	Max.	Unit	Condition
Emitter						
Forward Voltage	V_F	—	1.2	1.5	V	$I_F=10\text{ mA}$
Reverse Current	I_R	—	—	10	μA	$V_R=3.0\text{ V}$
Capacitance	C_O	—	50	—	pF	$V_R=0, f=1.0\text{ MHz}$
Detector						
Forward Blocking Voltage	V_{DM}	400	—	—	V	$R_{GK}=10\text{ K}\Omega$ $T_A=100^\circ\text{C}$ $I_d=150\text{ }\mu\text{A}$
Reverse Blocking Voltage	V_{DM}	400	—	—	V	
On-state Voltage	V_t	—	1.1	1.3	V	$I_T=300\text{ mA}$
Holding Current	I_H	—	—	500	μA	$R_{GK}=27\text{ K}\Omega$ $V_{FX}=50\text{ V}$
Gate Trigger Voltage	V_{GT}	—	0.6	1.0	V	$V_{FX}=100\text{ V}$ $R_{GK}=27\text{ K}\Omega$ $R_L=10\text{ K}\Omega$
Forward Leakage Current	I_R	—	150	—	μA	$R_{GK}=10\text{ K}\Omega$ $V_{RM}=400\text{ V}$ $I_F=0, T_A=100^\circ\text{C}$
Reverse Leakage Current	I_R	—	150	—	μA	$R_{GK}=10\text{ K}\Omega$ $V_{RX}=400\text{ V}$ $I_F=0, T_A=100^\circ\text{C}$
Gate Trigger Current	I_{GT}	—	20	50	μA	$V_{FX}=100\text{ V}$ $R_{GK}=27\text{ K}\Omega$ $R_L=10\text{ K}\Omega$
Capacitance Anode to Gate Gate to Cathode	—	—	20 350	—	pF pF	$V=0, f=1.0\text{ MHz}$
Package						
Turn-On Current H11C4/H11C5 H11C6	I_{FT}	—	—	20 30	mA mA	$V_{DM}=50\text{ V}$ $R_{GK}=10\text{ K}\Omega$
Turn-On Current H11C4/H11C5 H11C6	I_{FT}	—	5.0 7.0	11 14	mA mA	$V_{DM}=100\text{ V}$ $R_{GK}=27\text{ K}\Omega$